

## MOS FIELD EFFECT TRANSISTOR NP83P04PDG

### SWITCHING P-CHANNEL POWER MOSFET

#### **DESCRIPTION**

The NP83P04PDG is P-channel MOS Field Effect Transistor designed for high current switching applications.

#### <R> ORDERING INFORMATION

PART NUMBER	LEAD PLATING	PACKING	PACKAGE		
NP83P04PDG-E1-AY Note		Tana 000 m/mad	TO 202 (MD 257D)		
NP83P04PDG-E2-AY Note	Pure Sn (Tin)	Tape 800 p/reel	TO-263 (MP-25ZP)		

Note Pb-free (This product does not contain Pb in external electrode.)

#### **FEATURES**

• Super low on-state resistance

 $R_{DS(on)1} = 5.3 \text{ m}\Omega \text{ MAX.}$  (Vgs = -10 V, ID = -41.5 A)

 $R_{DS(on)2} = 8.0 \text{ m}\Omega \text{ MAX.} \text{ (Vgs} = -4.5 \text{ V, I}_D = -41.5 \text{ A})$ 

• High current rating: I<sub>D(DC)</sub> = ∓83 A

#### ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage (V <sub>GS</sub> = 0 V)	VDSS	-40	V
Gate to Source Voltage (VDS = 0 V)	Vgss	∓20	V
Drain Current (DC) (Tc = 25°C)	I <sub>D(DC)</sub>	∓83	Α
Drain Current (pulse) Note1	D(pulse)	∓249	Α
Total Power Dissipation (Tc = 25°C)	P <sub>T1</sub>	150	W
Total Power Dissipation (T <sub>A</sub> = 25°C)	P <sub>T2</sub>	1.8	W
Channel Temperature	Tch	175	°C
Storage Temperature	Tstg	-55 to +175	°C
Single Avalanche Current Note2	las	56	Α
Single Avalanche Energy Note2	Eas	315	mJ

**Notes 1.** PW  $\leq$  10  $\mu$ s, Duty Cycle  $\leq$  1%

2. Starting T<sub>ch</sub> = 25°C, V<sub>DD</sub> = -30 V, R<sub>G</sub> = 25  $\Omega$ , V<sub>GS</sub> =  $-20 \rightarrow 0$  V

#### THERMAL RESISTANCE

Channel to Case Thermal Resistance	Rth(ch-C)	1.0	°C/W	
Channel to Ambient Thermal Resistance	Rth(ch-A)	83.3	°C/W	

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(TO-263)



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#### **ELECTRICAL CHARACTERISTICS (TA = 25°C)**

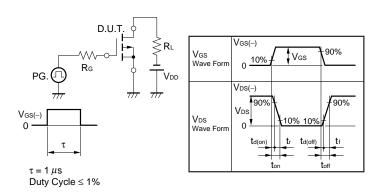
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	V <sub>DS</sub> = -40 V, V <sub>GS</sub> = 0 V			-10	μΑ
Gate Leakage Current	Igss	V <sub>GS</sub> = ∓20 V, V <sub>DS</sub> = 0 V			∓100	nA
Gate to Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = -10 V, I <sub>D</sub> = -1 mA	-1.0	-1.6	-2.5	V
Forward Transfer Admittance Note	y <sub>fs</sub>	V <sub>DS</sub> = -10 V, I <sub>D</sub> = -41.5 A	30	60		S
Drain to Source On-state Resistance Note	RDS(on)1	V <sub>GS</sub> = -10 V, I <sub>D</sub> = -41.5 A		4.1	5.3	mΩ
	R <sub>DS(on)2</sub>	V <sub>GS</sub> = -4.5 V, I <sub>D</sub> = -41.5 A		5.1	8.0	mΩ
Input Capacitance	Ciss	V <sub>DS</sub> = -10 V,		9820		pF
Output Capacitance	Coss	V <sub>GS</sub> = 0 V,		1500		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		850		pF
Turn-on Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> = -20 V, I <sub>D</sub> = -41.5 A,		35		ns
Rise Time	tr	V <sub>GS</sub> = -10 V,		21		ns
Turn-off Delay Time	td(off)	R <sub>G</sub> = 0 Ω		245		ns
Fall Time	tf			120		ns
Total Gate Charge	Q <sub>G</sub>	$V_{DD} = -32 \text{ V},$		200		nC
Gate to Source Charge	Q <sub>GS</sub>	V <sub>GS</sub> = -10 V,		25		nC
Gate to Drain Charge	Q <sub>GD</sub>	I <sub>D</sub> = -83 A		53		nC
Body Diode Forward Voltage Note	V <sub>F(S-D)</sub>	I <sub>F</sub> = -83 A, V <sub>GS</sub> = 0 V		0.93	1.5	V
Reverse Recovery Time	trr	I <sub>F</sub> = -83 A, V <sub>GS</sub> = 0 V,		57		ns
Reverse Recovery Charge	Qrr	di/dt = –100 A/μs		92		nC

**Note** Pulsed test PW  $\leq$  350  $\mu$ s, Duty Cycle  $\leq$  2%

#### **TEST CIRCUIT 1 AVALANCHE CAPABILITY**

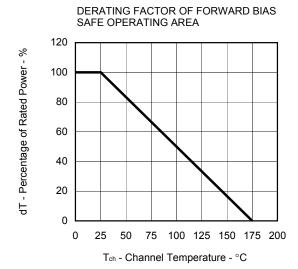
# $V_{GS} = -20 \rightarrow 0 \text{ V}$ $V_{DD}$ $V_{DD}$

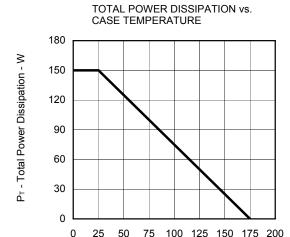
#### **TEST CIRCUIT 2 SWITCHING TIME**



#### **TEST CIRCUIT 3 GATE CHARGE**

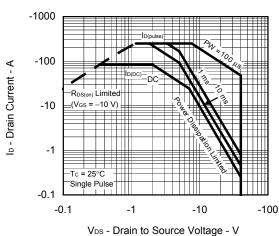
#### TYPICAL CHARACTERISTICS (TA = 25°C)



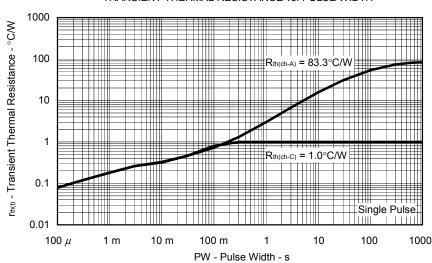


Tc - Case Temperature - °C

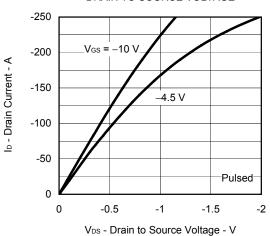
#### FORWARD BIAS SAFE OPERATING AREA



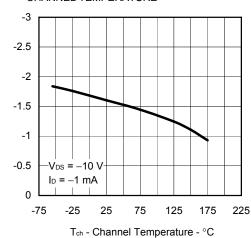
#### TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



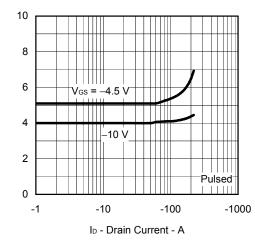




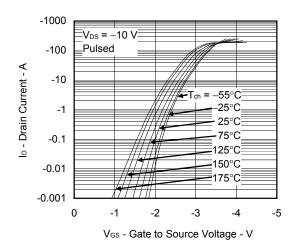
GATE TO SOURCE THRESHOLD VOLTAGE vs. CHANNEL TEMPERATURE



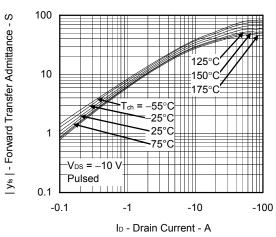
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



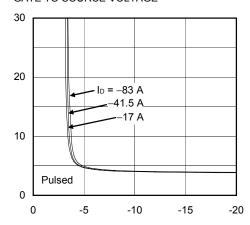
#### FORWARD TRANSFER CHARACTERISTICS



FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

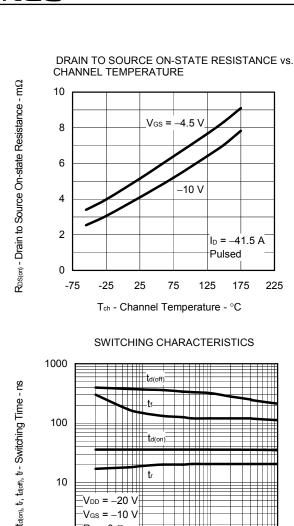


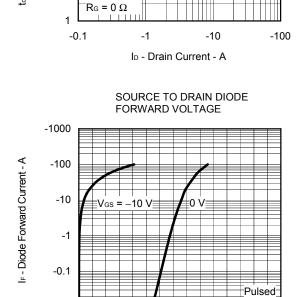
V<sub>GS</sub> - Gate to Source Voltage - V

R<sub>DS(o1)</sub> - Drain to Source On-state Resistance - mΩ

Ves(th) - Gate to Source Threshold Voltage - V

RDS(on) - Drain to Source On-state Resistance - mΩ



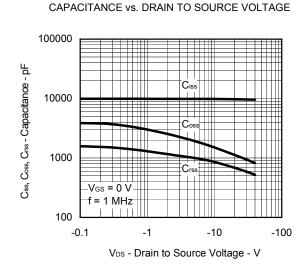


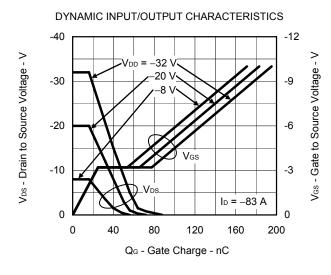
0.5

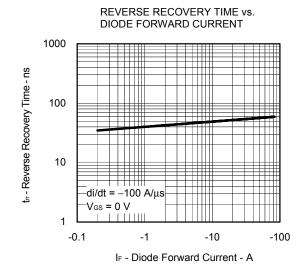
 $V_{F(S-D)}$  - Source to Drain Voltage - V

-0.01

0



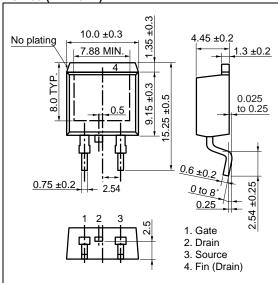




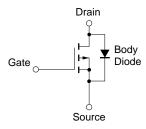
1.5

#### PACKAGE DRAWING (Unit: mm)

#### TO-263 (MP-25ZP)



#### **EQUIVALENT CIRCUIT**



**Remark** Strong electric field, when exposed to this device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it once, when it has occurred.

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